

CY54FCT573ATLMB Datasheet



DiGi Electronics Part Number

CY54FCT573ATLMB-DG

Manufacturer

Texas Instruments

Manufacturer Product Number

CY54FCT573ATLMB

Description

IC D-TYPE TRANSP SGL 8:8 20LCCC

Detailed Description

D-Type Transparent Latch 1 Channel 8:8 IC Tri-Stat

e, Non-Inverted 20-LCCC (8.89x8.89)

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Purchase and inquiry

Manufacturer Product Number:	Manufacturer:
CY54FCT573ATLMB	Texas Instruments
Series:	Product Status:
54FCT	Active
Logic Type:	Circuit:
D-Type Transparent Latch	8:8
Output Type:	Voltage - Supply:
Tri-State, Non-Inverted	4.5V ~ 5.5V
Independent Circuits:	Delay Time - Propagation:
1	9.8ns
Current - Output High, Low:	Operating Temperature:
12mA, 32mA	-55°C ~ 125°C
Mounting Type:	Package / Case:
Surface Mount	20-CLCC
Supplier Device Package:	
20-LCCC (8.89x8.89)	

Environmental & Export classification

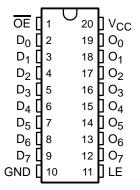
RoHS Status:	Moisture Sensitivity Level (MSL):
ROHS3 Compliant	Not Applicable

CY54FCT573T, CY74FCT573T 8-BIT LATCHES WITH 3-STATE OUTPUTS

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- Function and Pinout Compatible With FCT and F Logic
- Reduced V_{OH} (Typically = 3.3 V) Versions of Equivalent FCT Functions
- Edge-Rate Control Circuitry for Significantly Improved Noise Characteristics
- I_{off} Supports Partial-Power-Down Mode Operation
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)
- Matched Rise and Fall Times
- Fully Compatible With TTL Input and Output Logic Levels
- 3-State Outputs
- CY54FCT573T
 - 32-mA Output Sink Current
 - 12-mA Output Source Current
- CY74FCT573T
 - 64-mA Output Sink Current
 - 32-mA Output Source Current

CY54FCT573T . . . D PACKAGE CY74FCT573T . . . P, Q, OR SO PACKAGE (TOP VIEW)



description

The 'FCT573T devices consist of eight latches with 3-state outputs for bus-organized applications. When the latch-enable (LE) input is high, the flip-flops appear transparent to the data. Data that meets the required setup times are latched when LE transitions from high to low. Data appears on the bus when the output-enable (\overline{OE}) input is low. When \overline{OE} is high, the bus output is in the high-impedance state. In this mode, data can be entered into the latches. The 'FCT573T devices are identical to the 'FCT373T devices, except for the flow-through pinout of the 'FCT573T, which simplifies board design.

These devices are fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



CY54FCT573T, CY74FCT573T 8-BIT LATCHES WITH 3-STATE OUTPUTS

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ORDERING INFORMATION

TA	PAC	KAGE†	SPEED (ns)	ORDERABLE PART NUMBER	TOP-SIDE Marking
	QSOP - Q	Tape and reel	4.7	CY74FCT573CTQCT	FCT573C
	SOIC - SO	Tube	4.7	CY74FCT573CTSOC	FCT573C
4000 4 0500	30IC = 30	Tape and reel	4.7	CY74FCT573CTSOCT	FC1573C
	DIP – P	Tube	5.2	CY74FCT573ATPC	CY74FCT573ATPC
40°C to 95°C	QSOP – Q	Tape and reel	5.2	CY74FCT573ATQCT	FCT573A
-40 C to 65 C	SOIC - SO	Tube	5.2	CY74FCT573ATSOC	FCT573A
–40°C to 85°C	30IC = 30	Tape and reel	5.2	CY74FCT573ATSOCT	FC1575A
	QSOP – Q	Tape and reel	8	CY74FCT573TQCT	FCT573
	SOIC - SO	Tube	8	CY74FCT573TSOC	FCT573
	3010 - 30	Tape and reel	8	CY74FCT573TSOCT	FC13/3
–55°C to 125°C	CDIP – D	Tube	8.5	CY54FCT573ATLMB	

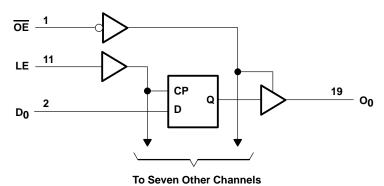
[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

	INPUTS		OUTPUT
OE	LE	D	0
L	Н	Н	Н
L	Н	L	L
L	L	Χ	Q_0
Н	X	X	Z

H = High logic level, L = Low logic level, X = Don't care, Z = High-impedance state, Q_D = Previous state of flip flops (Q_{D-1})

logic diagram (positive logic)



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absolute maximum rating over operating free-air temperature range (unless otherwise noted)†

Supply voltage range to ground potential		0.5	V to 7 V
DC input voltage range		0.5	V to 7 V
DC output voltage range		0.5	\mbox{V} to 7 \mbox{V}
DC output current (maximum sink current/pin)			120 mA
Package thermal impedance, θ_{JA} (see Note 1):	: P package		69°C/W
	Q package		68°C/W
	SO package		58°C/W
Ambient temperature range with power applied	I, T _A	–65°C	to 135°C
Storage temperature range, T _{stq}		–65°C	to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions (see Note 2)

		CY54FCT573T			CY7	3T	UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.8			0.8	V
ІОН	High-level output current			-12			-32	mA
loL	Low-level output current			32			64	mA
T _A	Operating free-air temperature	-55		125	-40		85	°C

NOTE 2: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation.



NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.

CY54FCT573T, CY74FCT573T 8-BIT LATCHES WITH 3-STATE OUTPUTS

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		TEST CONDITIONS			54FCT57	'3T	CY	74FCT57	73T	
PARAMETER		TEST CONDITIO	ONS	MIN	TYP [†]	MAX	MIN	TYP [†]	MAX	UNIT
V/	$V_{CC} = 4.5 \text{ V},$	I _{IN} = -18 mA			-0.7	-1.2				V
VIK	$V_{CC} = 4.75 \text{ V},$	I _{IN} = -18 mA						-0.7	-1.2	v v
	$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -12 \text{ mA}$		2.4	3.3					
Vон	V _{CC} = 4.75 V	$I_{OH} = -32 \text{ mA}$					2			V
	VCC = 4.75 V	$I_{OH} = -15 \text{ mA}$					2.4	3.3		
Va	$V_{CC} = 4.5 \text{ V},$	I _{OL} = 32 mA			0.3	0.55				V
VOL	$V_{CC} = 4.75 \text{ V},$	I _{OL} = 64 mA						0.3	0.55	v
V_{hys}	All inputs				0.2			0.2		V
	V _{CC} = 5.5 V,	VIN = VCC				5				4
t _l	V _{CC} = 5.25 V,	VIN = VCC							5	μΑ
	$V_{CC} = 5.5 \text{ V},$	V _{IN} = 2.7 V				±1				
lΗ	V _{CC} = 5.25 V,	V _{IN} = 2.7 V							±1	μΑ
1	V _{CC} = 5.5 V,	V _{IN} = 0.5 V				±1				
Iμ	V _{CC} = 5.25 V,	V _{IN} = 0.5 V							±1	μΑ
1	V _{CC} = 5.5 V,	V _{OUT} = 2.7 V				10				
IOZH	V _{CC} = 5.25 V,	V _{OUT} = 2.7 V							10	μΑ
1	$V_{CC} = 5.5 \text{ V},$	V _{OUT} = 0.5 V				-10				
IOZL	$V_{CC} = 5.25 \text{ V},$	V _{OUT} = 0.5 V							-10	μΑ
ı †	$V_{CC} = 5.5 \text{ V},$	V _{OUT} = 0 V		-60	-120	-225				A
IOS [‡]	$V_{CC} = 5.25 \text{ V},$	V _{OUT} = 0 V					-60	-120	-225	mA
I _{off}	$V_{CC} = 0 V$,	V _{OUT} = 4.5 V				±1			±1	μΑ
	V _{CC} = 5.5 V,	V _{IN} ≤ 0.2 V,	$V_{IN} \ge V_{CC} - 0.2 \text{ V}$		0.1	0.2				A
ICC	V _{CC} = 5.25 V,	V _{IN} ≤ 0.2 V,	$V_{IN} \ge V_{CC} - 0.2 \text{ V}$					0.1	0.2	mA
41	V _{CC} = 5.5 V, V _I	$N = 3.4 \text{ V}$, $f_1 = 0$, C	utputs open		0.5	2				A
∇ICC	V _{CC} = 5.25 V, V	$I_{1N} = 3.4 \text{ V}$, $f_1 = 0$,	Outputs open					0.5	2	mA
	V _{CC} = 5.5 V, Ou One input switch	itputs open, ning at 50% duty cyc	le, OE = GND,		0.06	0.12				
10.5-¶		$IN \ge V_{CC} - 0.2 \text{ V}$	· ,	<u> </u>						mA/
ICCD¶		Outputs open, ning at 50% duty cyc IN ≥ VCC - 0.2 V	le, OE = GND,					0.06	0.12	MHz

[†] Typical values are at V_{CC} = 5 V, T_A = 25°C.



^{\$\}frac{1}{2}\$ Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample-and-hold techniques are preferable to minimize internal chip heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output can raise the chip temperature well above normal and cause invalid readings in other parametric tests. In any sequence of parameter tests, IOS tests should be performed last.

[§] Per TTL-driven input (V_{IN} = 3.4 V); all other inputs at V_{CC} or GND

[¶] This parameter is derived for use in total power-supply calculations.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted) (continued)

PARAMETER		TEST CONDITION	e	CY	54FCT57	73T	CY74FCT573T			UNIT	
PARAMETER	TEST CONDITIONS			MIN	TYP [†]	MAX	MIN	TYP [†]	MAX	UNIT	
	V _{CC} = 5.5 V,	One bit switching at f ₁ = 10 MHz	$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$		0.7	1.4					
	Outputs open,	at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$		1	2.4					
	OE = GND, LE = V _{CC}	OE = GND, Fight bits switching	$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$		1.3	2.6					
I _C #		at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$		3.3	10.6				mA	
I IC"	$V_{CC} = 5.25 \text{ V},$ Outputs open, $\overline{OE} = \text{GND},$ $\text{LE} = V_{CC}$	One bit switching at $f_1 = 10 \text{ MHz}$	$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$					0.7	1.4	IIIA	
		at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$					1	2.4		
				$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$					1.3	2.6	
		at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$					3.3	10.6		
C _i					6	10		6	10	pF	
Co		_			8	12		8	12	pF	

[†] Typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

Where:

IC = Total supply current

I_{CC} = Power-supply current with CMOS input levels

 ΔI_{CC} = Power-supply current for a TTL high input (V_{IN} = 3.4 V)

 D_H = Duty cycle for TTL inputs high N_T = Number of TTL inputs at D_H

ICCD = Dynamic current caused by an input transition pair (HLH or LHL)

= Clock frequency for registered devices, otherwise zero

f₁ = Input signal frequency

N₁ = Number of inputs changing at f₁

All currents are in milliamperes and all frequencies are in megahertz.

Values for these conditions are examples of the I_{CC} formula.

timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

		CY54FC	T573T	CY54FCT	UNIT	
		MIN	MAX	MIN	MAX	UNIT
t _W	Pulse duration, LE high	6		6		ns
t _{su}	Setup time, data before LE↑	2		2		ns
th	Hold time, data after LE↑	1.5		1.5		ns

timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

		CY74FCT573T CY74FCT573AT		CY74FCT	573CT	UNIT		
		MIN	MAX	MIN	MAX	MIN	MAX	UNIT
t _W	Pulse duration, LE high	6		5		5		ns
t _{su}	Setup time, data before LE↑	2		2		2		ns
th	Hold time, data after LE↑	1.5		1.5		1.5	·	ns



 $^{^{\#}}$ IC = ICC + \triangle ICC \times DH \times NT + ICCD (f₀/2 + f₁ \times N₁)

CY54FCT573T, CY74FCT573T **8-BIT LATCHÉS** WITH 3-STATE OUTPUTS SCCS068 – OCTOBER 2001

switching characteristics over operating free-air temperature range (see Figure 1)

PARAMETER	FROM	то	CY54FCT	UNIT	
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	UNIT
^t PLH	D	0	1.5	5.6	nc
^t PHL	ע	O	1.5	5.6	ns
t _{PLH}	LE	0	2	9.8	no
^t PHL	LE	O	2	9.8	ns
^t PZH	ŌĒ	0	1.5	7.5	20
t _{PZL}	OE .	0		7.5	ns
^t PHZ	ŌĒ	0	1.5	6.5	ns
t _{PLZ}	OE .	J I	1.5	6.5	115

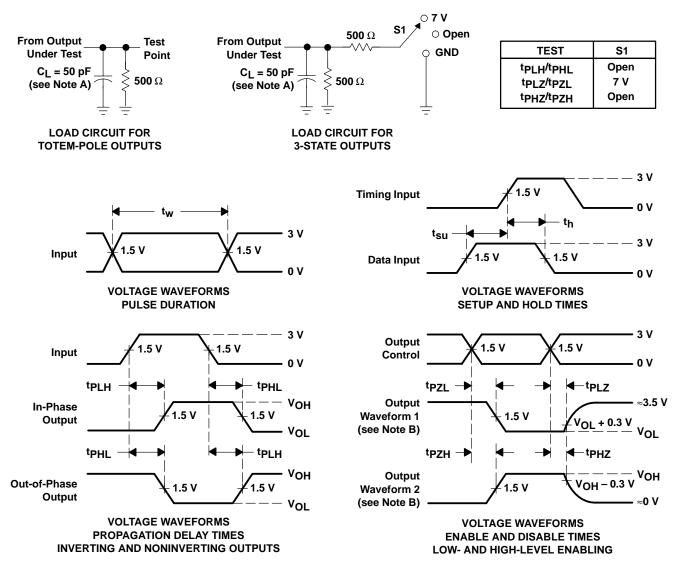
switching characteristics over operating free-air temperature range (see Figure 1)

PARAMETER	FROM	TO (OUTPUT)	TO CY74FCT573T		CY74FC1	573AT	CY74FCT573CT		UNIT
PARAMETER	(INPUT)		MIN	MAX	MIN	MAX	MIN	MAX	UNIT
t _{PLH}	D	0	1.5	8	1.5	5.2	1.5	4.7	ns
^t PHL	Ь		1.5	8	1.5	5.2	1.5	4.7	110
t _{PLH}	LE	0	2	13	2	8.5	2	5.5	
^t PHL		O	2	13	2	8.5	2	5.5	ns
^t PZH	ŌĒ	0	1.5	12	1.5	6.5	1.5	5.5	
t _{PZL}	OE	0	1.5	12	1.5	6.5	1.5	5.5	ns
t _{PHZ}	ŌĒ	0	1.5	7.5	1.5	5.5	1.5	5	ns
t _{PLZ}	OE	0	1.5	7.5	1.5	5.5	1.5	5	115



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PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



PACKAGE OPTION ADDENDUM

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9223801MRA	ACTIVE	CDIP	J	20	20	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9223801MR A	Samples
5962-9223802M2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9223802M2A CY54FCT 573ATLMB	Samples
CY54FCT573ATLMB	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9223802M2A CY54FCT 573ATLMB	Samples
CY74FCT573ATPC	ACTIVE	PDIP	N	20	20	RoHS & Non-Green	NIPDAU	N / A for Pkg Type	-40 to 85	CY74FCT573ATPC	Samples
CY74FCT573ATQCT	ACTIVE	SSOP	DBQ	20	2500	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FCT573A	Samples
CY74FCT573ATSOC	ACTIVE	SOIC	DW	20	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT573A	Samples
CY74FCT573ATSOCT	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT573A	Samples
CY74FCT573CTQCT	ACTIVE	SSOP	DBQ	20	2500	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FCT573C	Samples
CY74FCT573CTSOC	ACTIVE	SOIC	DW	20	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT573C	Samples
CY74FCT573TQCT	ACTIVE	SSOP	DBQ	20	2500	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FCT573	Samples
CY74FCT573TSOC	ACTIVE	SOIC	DW	20	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT573	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

⁽²⁾ **RoHS**: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

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Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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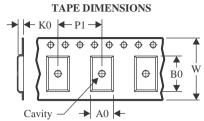


PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CY74FCT573ATQCT	SSOP	DBQ	20	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CY74FCT573ATSOCT	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
CY74FCT573CTQCT	SSOP	DBQ	20	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CY74FCT573TQCT	SSOP	DBQ	20	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1



PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

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Device	Device Package Type		Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CY74FCT573ATQCT	SSOP	DBQ	20	2500	356.0	356.0	35.0
CY74FCT573ATSOCT	SOIC	DW	20	2000	367.0	367.0	45.0
CY74FCT573CTQCT	SSOP	DBQ	20	2500	356.0	356.0	35.0
CY74FCT573TQCT	SSOP	DBQ	20	2500	356.0	356.0	35.0



PACKAGE MATERIALS INFORMATION

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TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-9223802M2A	FK	LCCC	20	55	506.98	12.06	2030	NA
CY54FCT573ATLMB	FK	LCCC	20	55	506.98	12.06	2030	NA
CY74FCT573ATPC	N	PDIP	20	20	506	13.97	11230	4.32
CY74FCT573ATSOC	DW	SOIC	20	25	507	12.83	5080	6.6
CY74FCT573CTSOC	DW	SOIC	20	25	507	12.83	5080	6.6
CY74FCT573TSOC	DW	SOIC	20	25	507	12.83	5080	6.6

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